Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/634,845	MURAYAMA ET AL.
	Examiner	Art Unit
	Jeffrey G. Hoekstra	3736

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Class	Subclass	Date	Examiner
600	585	12/6/2005	JGH
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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